

Search Notes

Application/Control No.

09/818,567

Examiner

Ellen C. Tran

Applicant(s)/Patent under
Reexamination

FURUYA ET AL.

Art Unit

2134

SEARCHED

Class	Subclass	Date	Examiner
380	28	5/25/2005	ECT
380	200	5/25/2005	ECT
380	210	5/25/2005	ECT
713	169	5/25/2005	ECT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH	5/25/2005	ECT